

ISO K Line Serial Link Interface

The 33290 is a serial link bus interface device designed to provide bi-directional half-duplex communication interfacing in automotive diagnostic applications. It is designed to interface between the vehicle's on-board microcontroller and systems off-board the vehicle via the special ISO K line. The 33290 is designed to meet the Diagnostic Systems ISO9141 specification. The device's K line bus driver's output is fully protected against bus shorts and overtemperature conditions.

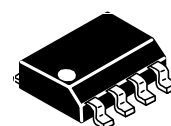
The 33290 derives its robustness to temperature and voltage extremes by being built on a *SMARTMOS™* process, incorporating CMOS logic, bipolar/MOS analog circuitry, and DMOS power FETs. Although the 33290 was principally designed for automotive applications, it is suited for other serial communication applications. It is parametrically specified over an ambient temperature range of $-40^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$ and $8.0\text{ V} \leq V_{\text{BB}} \leq 18\text{ V}$ supply. The economical SO-8 surface-mount plastic package makes the 33290 very cost effective.

Features

- Designed to Operate Over Wide Supply Voltage of 8.0 to 18 V
- Ambient Operating Temperature of -40 to 125°C
- Interfaces Directly to Standard CMOS Microprocessors
- ISO K Line Pin Protected Against Shorts to Ground
- Thermal Shutdown with Hysteresis
- Maximum Transmission Speeds in Excess of 50 k Baud
- ISO K Line Pin Capable of High Currents
- ISO K Line Can Be Driven with up to 10 nF of Parasitic Capacitance
- 8.0 kV ESD Protection Attainable with Few Additional Components
- Standby Mode: No V_{Bat} Current Drain with V_{DD} at 5.0 V
- Low Current Drain During Operation with V_{DD} at 5.0 V

33290

ISO K LINE SERIAL LINK INTERFACE

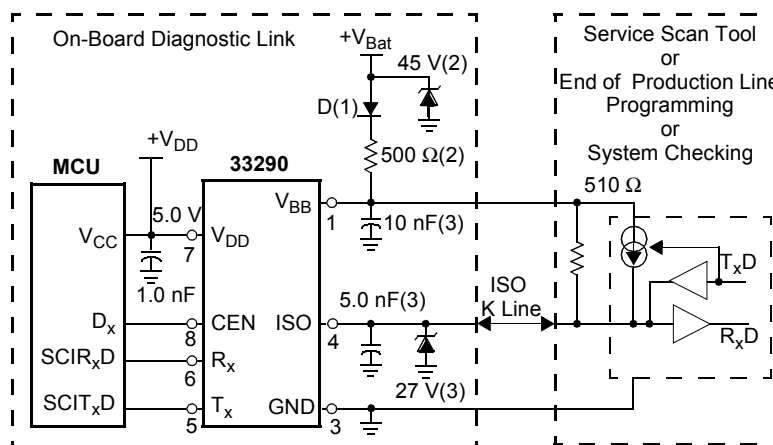


D SUFFIX
PLASTIC PACKAGE
CASE 751
(SO-8)

ORDERING INFORMATION

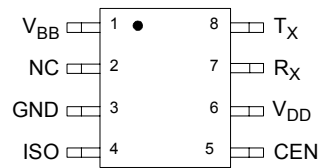
Device	Temperature Range (T_A)	Package
MC33290D	-40 to 125°C	SO-8

33290 Simplified Application Diagram



Components necessary for Reverse Battery (1), Overvoltage Transient (2), and 8.0 kV ESD Protection (3) in a metal module case. This device contains 85 active transistors.





PIN FUNCTION DESCRIPTION

Pin Number	Pin Name	Description
1	V_{BB}	Battery power through external resistor and diode.
2	NC	Not to be connected. (Note 1)
3	GND	Common signal and power return.
4	ISO	Bus connection.
5	T_X	Logic level input for data to be transmitted on the bus.
6	R_X	Logic output of data received on the bus.
7	V_{DD}	Logic power source input.
8	CEN	Chip enable. Logic "1" for active state. Logic "0" for sleep state.

Notes:

1. NC pins should not have any connections made to them. NC pins are not guaranteed to be open circuits.

MAXIMUM RATINGS

All voltages are with respect to ground unless otherwise noted.

Rating	Symbol	Value	Unit
V _{DD} DC Supply Voltage	V _{DD}	-0.3 to 7.0	V
V _{BB} Load Dump Peak Voltage	V _{BB(LD)}	45	V
ISO Pin Load Dump Peak Voltage (Note 2)	V _{ISO}	40	V
ISO Short Circuit Current Limit	I _{ISO(LIM)}	1.0	A
ESD Voltage (Note 3) Human Body Model (Note 4) Machine Model (Note 5)	V _{ESD1} V _{ESD2}	2000 200	V
ISO Clamp Energy (Note 6)	E _{clamp}	10	mJ
Storage Temperature	T _{stg}	-55 to +150	°C
Operating Case Temperature	T _C	-40 to +125	°C
Operating Junction Temperature	T _J	-40 to +150	°C
Power Dissipation T _A = 25°C	P _D	0.8	W
Lead Soldering Temperature (Note 7)	T _{solder}	260	°C
Thermal Resistance Junction-to-Ambient	R _{θJA}	150	°C/W

Notes:

- Device will survive double battery jump start conditions in typical applications for 10 minutes duration, but is not guaranteed to remain within specified parametric limits during this duration.
- ESD data available upon request.
- ESD1 testing is performed in accordance with the Human Body Model (C_{ZAP} = 100 pF, R_{ZAP} = 1500 Ω).
- ESD2 testing is performed in accordance with the Machine Model (C_{ZAP} = 200 pF, R_{ZAP} = 0 Ω).
- Nonrepetitive clamping capability at 25°C.
- Lead soldering temperature limit is for 10 seconds maximum duration. Contact Motorola Sales Office for device immersion soldering time/temperature limits.

STATIC ELECTRICAL CHARACTERISTICS

Characteristics noted under conditions of $4.75\text{ V} \leq V_{DD} \leq 5.25\text{ V}$, $8.0\text{ V} \leq V_{BB} \leq 18\text{ V}$, $-40^\circ\text{C} \leq T_C \leq 125^\circ\text{C}$, unless otherwise noted.

Characteristic	Symbol	Min	Typ	Max	Unit
POWER AND CONTROL					
V_{DD} Sleep State Current $T_X = 0.8 V_{DD}$, $CEN = 0.3 V_{DD}$	$I_{DD(SS)}$	—	—	0.1	mA
V_{DD} Quiescent Operating Current $T_X = 0.2 V_{DD}$, $CEN = 0.7 V_{DD}$	$I_{DD(Q)}$	—	—	1.0	mA
V_{BB} Sleep State Current $V_{BB} = 16\text{ V}$, $T_X = 0.8 V_{DD}$, $CEN = 0.3 V_{DD}$	$I_{BB(SS)}$	—	—	50	μA
V_{BB} Quiescent Operating Current $T_X = 0.2 V_{DD}$, $CEN = 0.7 V_{DD}$	$I_{BB(Q)}$	—	—	1.0	mA
Chip Enable Input High-Voltage Threshold (Note 8) Input Low-Voltage Threshold (Note 9)	$V_{IH(CEN)}$ $V_{IL(CEN)}$	$0.7 V_{DD}$ —	— —	— $0.3 V_{DD}$	V
Chip Enable Pull-Down Current (Note 10)	$I_{PD(CEN)}$	2.0	—	40	μA
T_X Input Low-Voltage Threshold $R_{ISO} = 510\ \Omega$ (Note 11)	$V_{IL(TX)}$	—	—	$0.3 \times V_{DD}$	V
T_X Input High-Voltage Threshold $R_{ISO} = 510\ \Omega$ (Note 12)	$V_{IH(TX)}$	$0.7 \times V_{DD}$	—	—	V
T_X Pull-Up Current (Note 13)	$I_{PU(TX)}$	-40	—	-2.0	μA
R_X Output Low-Voltage Threshold $R_{ISO} = 510\ \Omega$, $T_X = 0.2 V_{DD}$, R_X Sinking 1.0 mA	$V_{OL(RX)}$	—	—	$0.2 V_{DD}$	V
R_X Output High-Voltage Threshold $R_{ISO} = 510\ \Omega$, $T_X = 0.8 V_{DD}$, R_X Sourcing 250 μA	$V_{OH(RX)}$	$0.8 V_{DD}$	—	—	V
Thermal Shutdown (Note 14)	T_{LIM}	150	170	—	$^\circ\text{C}$

Notes:

- When IBB transitions to $>100\ \mu\text{A}$.
- When IBB transitions to $<100\ \mu\text{A}$.
- Enable pin has an internal current pull-down equivalent to greater than 50 k Ω .
- Measured by ramping T_X down from $0.7 V_{DD}$ and noting T_X value at which ISO falls below $0.2 V_{BB}$.
- Measured by ramping T_X up from $0.3 V_{DD}$ and noting the value at which ISO rises above $0.9 V_{BB}$.
- T_X pin has internal current pull-up equivalent to greater than 50 k Ω . Pull-Up current measured with T_X pin at $0.7 V_{DD}$.
- Thermal Shutdown performance (T_{LIM}) is guaranteed by design but not production tested.

STATIC ELECTRICAL CHARACTERISTICS (continued)

Characteristics noted under conditions of $4.75\text{ V} \leq V_{DD} \leq 5.25\text{ V}$, $8.0\text{ V} \leq V_{BB} \leq 18\text{ V}$, $-40^{\circ}\text{C} \leq T_C \leq 125^{\circ}\text{C}$, unless otherwise noted.

Characteristic	Symbol	Min	Typ	Max	Unit
ISO I/O					
Input Low Voltage Threshold $R_{ISO} = 0\ \Omega$, $T_X = 0.8\ V_{DD}$ (Note 15)	$V_{IL(ISO)}$	–	–	$0.4 \times V_{BB}$	V
Input High Voltage Threshold $R_{ISO} = 0\ \Omega$, $T_X = 0.8\ V_{DD}$ (Note 16)	$V_{IH(ISO)}$	$0.7 \times V_{BB}$	–	–	V
Input Hysteresis (Note 17)	$V_{Hys(ISO)}$	$0.05 \times V_{BB}$	–	$0.1 \times V_{BB}$	V
Internal Pull-Up Current $R_{ISO} = \infty\ \Omega$, $T_X = 0.8\ V_{DD}$, $V_{ISO} = 9.0\text{ V}$, $V_{BB} = 18\text{ V}$	$I_{PU(ISO)}$	-5.0	–	-120	μA
Short Circuit Current Limit (Note 18) $R_{ISO} = 0\ \Omega$, $T_X = 0.4\ V_{DD}$, $V_{ISO} = V_{BB}$	$I_{SC(ISO)}$	50	–	1000	mA
Output Low Voltage $R_{ISO} = 510\ \Omega$, $T_X = 0.2\ V_{DD}$	$V_{OL(ISO)}$	–	–	$0.1 \times V_{BB}$	V
Output High Voltage $R_{ISO} = \infty\ \Omega$, $T_X = 0.8\ V_{DD}$	$V_{OH(ISO)}$	$0.95 \times V_{BB}$	–	–	V

Notes:

15. ISO ramped from $0.8\ V_{BB}$ to $0.4\ V_{BB}$. Monitor R_X . Value of ISO voltage at which R_X transitions to $0.3\ V_{DD}$.
16. ISO ramped from $0.4\ V_{BB}$ to $0.8\ V_{BB}$. Monitor R_X . Value of ISO voltage at which R_X transitions to $0.7\ V_{DD}$.
17. Input Hysteresis, $V_{Hys(ISO)} = V_{IH(ISO)} - V_{IL(ISO)}$.
18. ISO has internal current limiting.

DYNAMIC ELECTRICAL CHARACTERISTICS

Characteristics noted under conditions of $4.75\text{ V} \leq V_{DD} \leq 5.25\text{ V}$, $8.0\text{ V} \leq V_{BB} \leq 18\text{ V}$, $-40^\circ\text{C} \leq T_C \leq 125^\circ\text{C}$, unless otherwise noted.

Characteristic	Symbol	Min	Typ	Max	Unit
Fall Time (Note 19) $R_{ISO} = 510\ \Omega$ to V_{BB} , $C_{ISO} = 10\text{ nF}$ to Ground	$t_{fall(ISO)}$	–	–	2.0	μs
ISO Propagation Delay (Note 20) High to Low: $R_{ISO} = 510\ \Omega$, $C_{ISO} = 500\text{ pF}$ (Note 21) Low to High: $R_{ISO} = 510\ \Omega$, $C_{ISO} = 500\text{ pF}$ (Note 22)	$t_{PD(ISO)}$	– –	– –	2.0 2.0	μs

Notes:

19. Time required ISO voltage to transition from $0.8\ V_{BB}$ to $0.2\ V_{BB}$.
20. Changes in the value of C_{ISO} affect the rise and fall time but have minimal effect on Propagation Delay.
21. Step T_X voltage from $0.2\ V_{DD}$ to $0.8\ V_{DD}$. Time measured from $V_{IH(ISO)}$ until V_{ISO} reaches $0.3\ V_{BB}$.
22. Step T_X voltage from $0.8\ V_{DD}$ to $0.2\ V_{DD}$. Time measured from $V_{IL(ISO)}$ until V_{ISO} reaches $0.7\ V_{BB}$.

Electrical Performance Curves

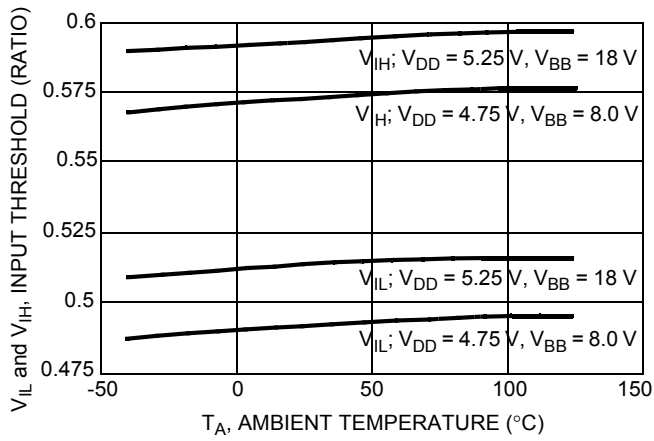


Figure 2. ISO Input Threshold/ V_{BB} vs. Temperature

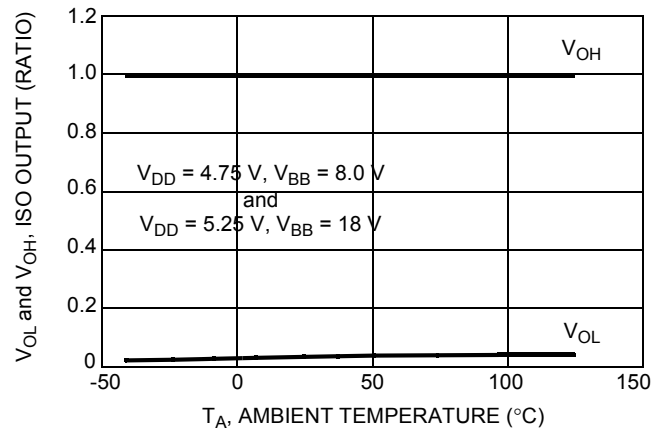


Figure 4. ISO Fall Time vs. Temperature

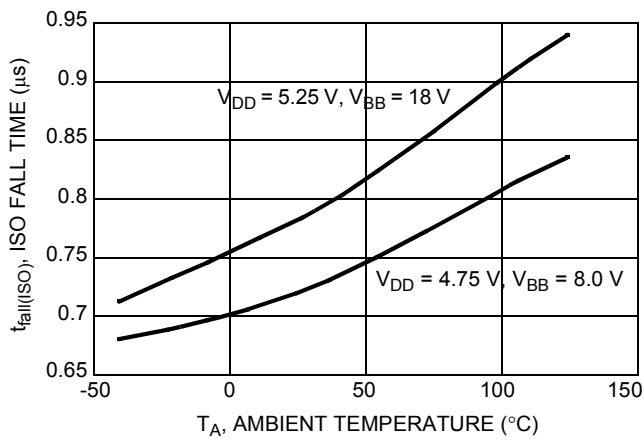


Figure 3. ISO Output/ V_{BB} vs. Temperature

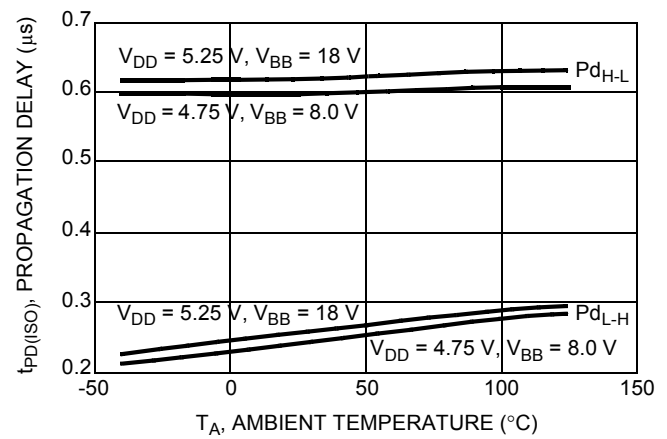


Figure 5. ISO Propagation Delay vs. Temperature

APPLICATIONS INFORMATION

INTRODUCTION

The 33290 is a serial link bus interface device conforming to the ISO 9141 physical bus specification. The device was designed for automotive environment usage compliant with On-Board Diagnostic (OBD) requirements set forth by the California Air Resources Board (CARB) using the ISO K line. The device does not incorporate an ISO L line. It provides bi-directional

half-duplex communications interfacing from a microcontroller to the communication bus. The 33290 incorporates circuitry to interface the digital translations from 5.0 V microcontroller logic levels to battery level logic and from battery level logic to 5.0 V logic levels. The 33290 is built using Motorola's *SMARTMOS*™ process and is packaged in an 8-pin plastic SOIC.

FUNCTIONAL DESCRIPTION

The 33290 transforms 5.0 V microcontroller logic signals to battery level logic signals and visa versa. This serial link interface device, operating in a typical automotive diagnostic application, operates at bit rates up to 10.4 kbps with less than 2.0 μ s propagation delay and less than 2.0 μ s fall time. Rise time is a function of the resistor used in the application to pull up the bus to battery voltage, working in conjunction with the total capacitance present on the bus. The serial link interface will remain fully functional over a battery voltage range of 6.0 to 18 V. The device is parametrically specified over a dynamic V_{BB} voltage range of 8.0 to 18 V.

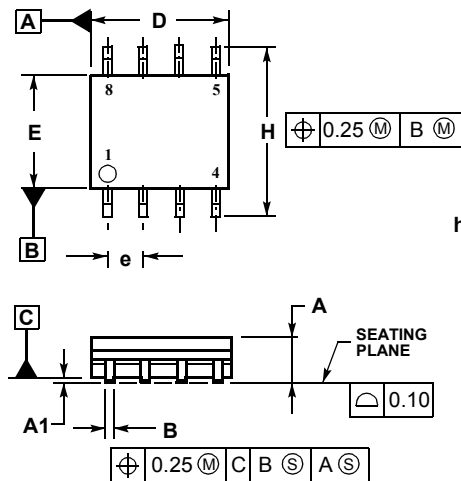
Required input levels from the microcontroller are ratio-metric with the V_{DD} voltage normally used to power the microcontroller. This enhances the 33290's ability to remain in harmony with the R_X and T_X control input signals of the microcontroller. The R_X and T_X control inputs are compatible with standard 5.0 V CMOS circuitry. For fault-tolerant purposes the T_X input from the microcontroller has an internal passive pull-up to V_{DD} of approximately 125 k Ω , while the CEN input has an internal passive pull-down to ground of approximately 125 k Ω .

In the receive mode, all ISO K Line bus input signals greater than the $0.7 \times V_{BB}$ thresholds are valid for a high-level signal and less than the $0.4 \times V_{BB}$ thresholds for a low-level signal. In the transmit mode, valid ISO K line bus output signal levels are greater than $0.95 \times V_{BB}$ and less than $0.1 \times V_{BB}$. A pull-up resistor of ≥ 100 k Ω to battery is internally provided as well as an active data pull-down. The internal active pull-down is current-limit-protected against shorts to battery and further protected by thermal shutdown. Typical applications have reverse battery protection by the incorporation of an external 510 Ω pull-up resistor and diode to battery.

Reverse battery protection of the device is provided by using a reverse battery blocking diode [(D) in the Simplified Application Diagram on page 1]. Battery line transient protection of the device is provided for by using a 45 V zener and a 500 Ω resistor connected to the V_{BB} source as shown in the same diagram. Device ESD protection from the communication lines exiting the module is through the use of the 10 nF connected to the V_{BB} device pin and the 5.0 nF used in conjunction with the 27 V zener connected to the ISO pin.

PACKAGE DIMENSIONS

D SUFFIX (8-LEAD SOIC) PLASTIC PACKAGE CASE 751-06 ISSUE T



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. DIMENSIONS ARE IN MILLIMETER.
3. DIMENSION D AND E DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
5. DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 TOTAL IN EXCESS OF THE B DIMENSION AT MAXIMUM MATERIAL CONDITION.

DIM	MILLIMETERS	
	MIN	MAX
A	1.35	1.75
A1	0.10	0.25
B	0.35	0.49
C	0.19	0.25
D	4.80	5.00
E	3.80	4.00
e	1.27 BSC	
H	5.80	6.20
h	0.25	0.50
L	0.40	1.25
θ	0°	7°

NOTES

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and are registered trademarks of Motorola, Inc. Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

MOTOROLA and the Stylized M Logo are registered in the US Patent and Trademark Office. All other product or service names are the property of their respective owners.

© Motorola, Inc. 2002

HOW TO REACH US:

USA/EUROPE/LOCATIONS NOT LISTED: Motorola Literature Distribution: P.O. Box 5405, Denver, Colorado 80217.

1-303-675-2140 or 1-800-441-2447

JAPAN: Motorola Japan Ltd.; SPS, Technical Information Center, 3-20-1 Minami-Azabu. Minato-ku, Tokyo 106-8573 Japan.

81-3-3440-3569

ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; Silicon Harbour Centre, 2 Dai King Street, Tai Po Industrial Estate, Tao Po, N.T.,

Hong Kong. 852-26668334

TECHNICAL INFORMATION CENTER: 1-800-521-6274



MOTOROLA

MC33290/D

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.